

Notice of References Cited

Application/Control No.

10/725,514

Applicant(s)/Patent Under
Reexamination
HEENEY ET AL.

Examiner

Shean C. Wu

Art Unit

1795

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,359,149	03-2002	Tan et al.	549/50
*	B	US-6,455,873	09-2002	Lonergan, Mark C.	257/40
	C	US-			
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	E	US-			
	F	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	English abstract for JP 05-312746, 1993
	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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